Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,181	BRABEC ET AL.	
Examiner	Art Unit	
Michael Y. Won	2155	

SEAR Subclass 205, 206, 207	Date	Examiner
205, 206,		Examiner
205, 206, 207	11/14/2007	
	11/14/2007	MW
205, 206, 207, 230, 246, 248	11/26/2007	MW
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	207, 230,	207, 230, 246, 248

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
709	206	11/26/2007	MW
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SEARCH N (INCLUDING SEAR		)
	DATE	EXMR
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	11/14/2007	M₩
NPL SEARCH: IEEE	11/15/2007	WW
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	11/26/2007	MW